

SINE WAVE TEST OF ADC'S: MEANS FOR INTERNATIONAL COMPARISON

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Abstract: ADC data sheets and test methods are not yet standardized. A new attempt to create a common platform for these is the draft standard IEEE-STD-1241. However, the methods described in this standard need an extra effort from the user to exactly understand and implement them. It is therefore very reasonable to provide programs which implement these methods, and allow manufacturers and users to use them. This assures that the same characterizing quantities will be used for the same purpose by everyone.

The first attempt for this was a LabView program announced in 1999. In this paper another implementation is presented, running under MATLAB. This will hopefully extend the number of the users of the methods described in the standard.

Keywords: IEEE-STD-1241, ADC testing, sine wave method, MATLAB, EUPAS.

1 INTRODUCTION

Analog-to-Digital Converters (ADC's) have been in use for more than 20 years. However, there is still no standard for the measurement and testing methods, which could be used by the manufacturers and by the users. So, two ADC's made by two different manufacturers are often not really comparable, because of the different test and measurement methods.

To fill this gap, IEEE¹ began new projects a couple of years ago. The aim of these projects is to standardize the terminology and test methods for both the digitizing waveform recorders [1] and the analog to digital converters [2]. The IMEKO TC4 Working Group on "A/D and D/A Converter Metrology", EUPAS², undertook the task to manage these standardization projects in Europe [3]. The two bodies work closely together.

There exists another initiative, Dynad [7] which deals with dynamic characterisation of ADC's. The programs and principles described in this paper relate also to this project, but the primary intention is to contribute to the IEEE standards. On long run, we should consider the development of a common test program.

In 1999, a LabView program was announced by a workgroup in the IEEE Instrumentation and Measurement Society TC-10 [5,6]. This is maybe the first widely available program to bring part of the methods described in the standards [1,2] into practice, in a standard form. It implements the sine wave test method.

The existence of this program induces further thinking on the applicability of the standard, on ways of distributing the standardized methods, etc. This is the topic of this paper. First we are going to discuss general aspects, then give a short overview of the LabView program, and finally discuss an alternative MATLAB implementation.

2 THE SINE WAVE TEST METHOD

Using only a few general methods, most of the tests presented in the IEEE standard can be performed. Maybe the most prevalent method is the sine wave test. The basic idea of the test is the following: a computer, connected to the ADC under test, measures the output, by applying a sine wave as excitation signal. From the samples the parameters of the sine wave are determined (using signal processing methods, e. g. DFT or parameter fitting). Finally, by subtracting the calculated sine wave from the samples, a residual vector is taken, suitable to describe several ADC properties, e. g. SINAD³ or THD⁴ [2].

¹ The Institute of Electrical and Electronics Engineers

² European Project for ADC-based devices Standardisation

³ Signal to noise and distortion ratio

⁴ Total harmonic distortion

3 IMPLEMENTATION: GENERAL CONSIDERATIONS

By studying the draft standard, one can quickly conclude that while most methods are straightforward, even the one-step algorithms may have different implementations. This means that the results can be slightly different. If this difference is significantly smaller than the error itself, this is not a problem. However, when the problem to be solved may have local minima, there is a chance for significantly different results. This is the case e.g. with the 4-parameter fitting. In other words, in such cases, users with different programs can conclude at different results, even starting from exactly the same data.

This problem can be overcome either by strictly defining the algorithms, which is very cumbersome, and often cannot be implemented by users of commercially available programs. Another possibility is to provide standard programs which can be used by anybody, for data processing or for comparison. We can state in general that the methods described in the standard should be available in the form of programs, too.

4 REQUIREMENTS FOR THE IMPLEMENTATION

Given the variety of computer platforms (PC, Macintosh, Sun, etc), and operating systems even on the PC's (Win2000, NT, Linux), a good solution cannot be just a set of executable programs. There are difficulties in simultaneous upgrading, in the differences between compilers, in necessity of system-dependent code segments, especially for the user interface, etc. Therefore, we should go for a program written for a compiler/interpreter available on most platforms, hiding possibly all differences, or at least a program running under the most common operating systems. Moreover, there is a clear need for easy and direct interfacing to the instrumentation, too. Candidates for these purposes are:

- Matlab [8]
- LabView [9]
- LabWindows [10]
- HP VEE [11]
- VisiDAQ, GeniDAQ [12]
- MATRIXx [13]
- Scilab [14]

The first implementation of the tools was written in LabView (see below). However, when comparing the above programs, MATLAB seems to be the most widely used one, available for many platforms. Therefore, it is reasonable to implement the data processing methods described in [2] also in MATLAB. This has the following advantages:

- MATLAB is available at many labs, for many platforms
- its numerical software is rather platform-independent
- its interpreter allows transparent coding (the source code can be examined by the user)
- it is open (it is rather easy to extend the existing code)

Therefore, our goal was to develop a MATLAB program which is

- compatible with the LabView program [5,6]
- freely available [19]
- is carefully documented to assure repeatability of the results by other programs, and assure that it can be used as a reference for comparisons
- can be easily extended with new code (to check new ideas)

Before discussing the MATLAB program, let us briefly overview the LabView one.

5 THE LABVIEW PROGRAM

The LabView program has been originally developed to test waveform recorders, but as the two standards use the same algorithm for sine wave fitting [1, 4.1.3.3] [2, 4.1.4.3], it can be used also to test Analog-to-Digital Converters. It implements most of the sine wave fitting tests, with coherent sampling, and contains some additional possibilities for visual evaluation (e.g. PSDF, mod T, see below).

The input data to the program are:

- the measured waveform record (sampled points, or sampling instants and sampled points),
- the sampling frequency (or the sampling instants as above), and
- the full-scale (min to max) value of the ADC.

Additional processing parameters (such as time limits to select the part of the record to be processed) can also be set manually. There is even a possibility to process more than one file, but the user has to make a descriptor for each file and scanning of the files is not automatic. To set all of these properties, there is an input window (VI), which automatically opens when the user starts the program (Fig. 1).

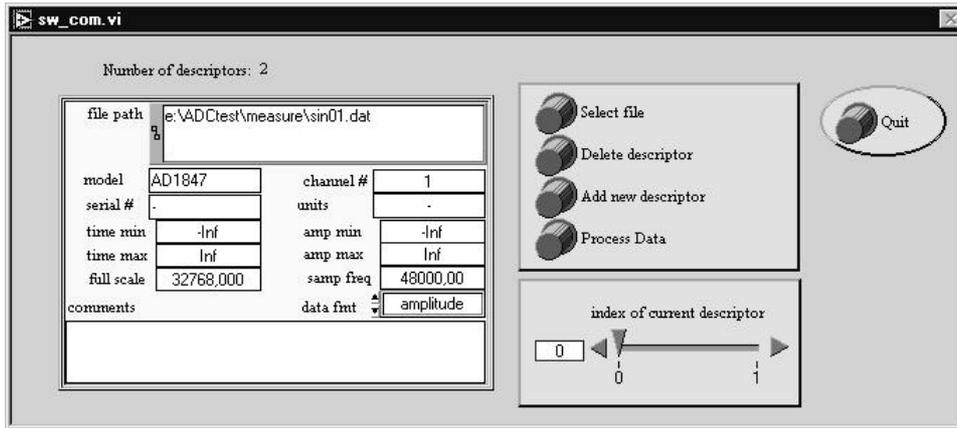


Figure 1: The input window of the LabView program

When pressing the “Process Data” button, the software fits a sine wave to the measured data, using 4-parameter LS fitting, and produces a single-window graphical output, along with two computer files which can be used for later analysis. One example is shown in Fig. 2. The graphical display shows information on the input data vector (“descriptive information”), some single-number outputs (“computed information”), calculated from the fitted sine wave, such as the estimated amplitude and frequency of the signals or the number of effective bits, and displays three different graphs.

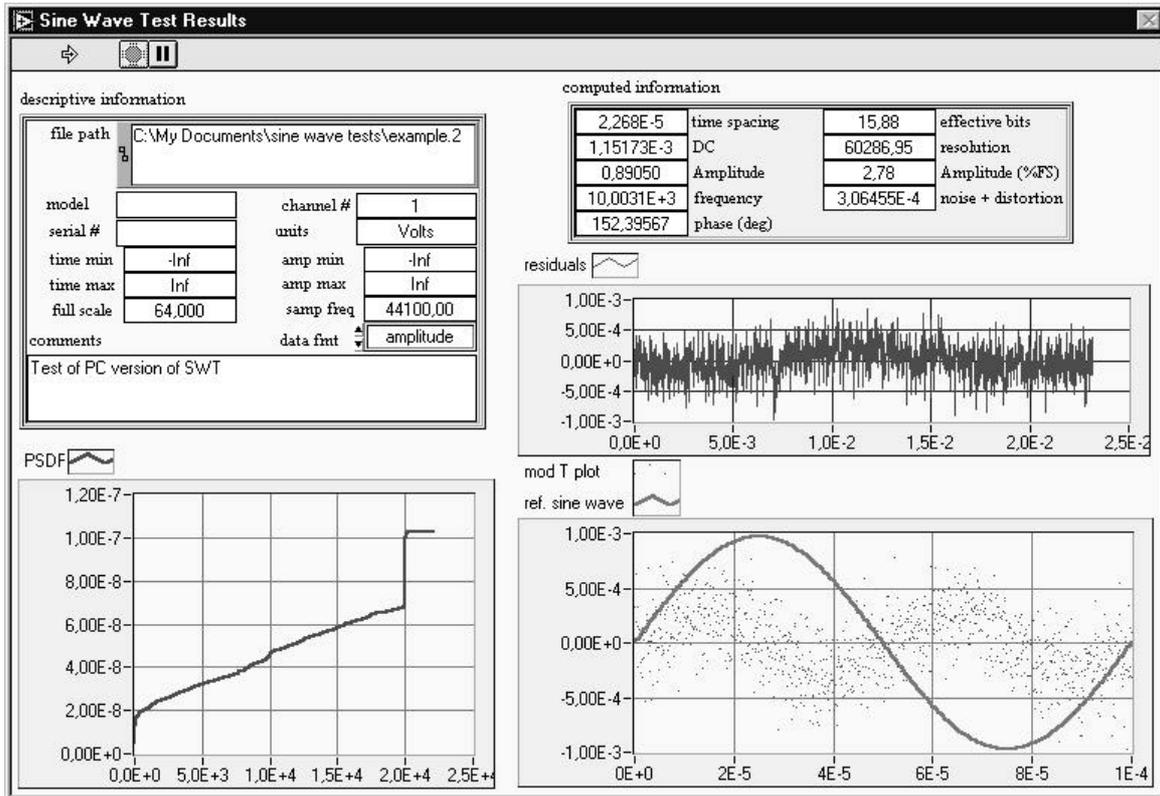


Figure 1: The graphical output of the LabView program

The graph “residuals” shows the difference between the input data and the fitted sine wave. With a usual set of data (more than 1000 samples) in such a small area, it gives rough information only.

The graph “mod T plot” gives more information about the behaviour of the residuals; it shows them as a function of the fitted sine wave phase instead of the time (the horizontal axis is wrapped by the period length). The plotted sine wave is a help only to illustrate the value of the phase. Studying this type of plot, it is very easy to determine that the measured device has 2nd harmonic distortion. There are several other properties which can be read from this modulo plot, for more information see [15].

The last graph, labelled “PSDF” shows the power spectral distribution function, the integral of the power spectral density. It gives a lot of useful qualitative and quantitative information about the residuals, such as time jitter and 2nd harmonic distortion [16].

6 THE MATLAB REALIZATION

Our first aim was to develop a MATLAB program which is graphically and algorithmically equivalent to the existing LabView software. The advantage of such a program is that both MATLAB and LabView users can use exactly the same algorithms, obtain the same results, and talk the same language when discussing ADC testing.

A further aim was to define and implement some additional features which can improve usefulness and interactivity of the software package. The main concept of the program is that while the computing procedures described in the standard are fixed, the other functionalities (input reading, output writing, logging, etc.) can be changeable by the user.

In the following subsections we discuss the main parts of the existing MATLAB software, along with the possibilities for extension.

6.1 Input Window of the Program

By default, the starting window is similar to the previously described LabView one (see Fig. 1). However, this is the point where we felt the strongest need for extensions. Depending on the future possibility to extend the LabView program hand-in-hand with the MATLAB one, we suggest the following, either by default, or as an "advanced mode".

If the user would like to process a lot of measured data from the same type device (e. g. quality control), it is very uncomfortable to fill out one descriptor for each file (or just change the file name in each new descriptor). To make the program more efficient, both multiple file opening and wildcards using (e. g. *, ?) should be enabled.

Another delicate matter is the input file format. The more the number of the measuring devices/software versions, the more the different file formats will be. Therefore, the "usability" of this program considerably depends of the input file format handling. Therefore we suggest to offer three different formats.

The first one is the compatible format, where only the samples or the samples and the time data are in a tab-separated input ASCII file. We allow fixed-point, floating point and hexadecimal format of the numbers. This format is also suitable to process automatically uploaded and saved memory fields from the DUT without editing the source files manually.

The second choice is to use a precisely defined but flexible input file format. It is very useful when the user would like to process a lot of files with different settings (e. g. to compare a lot of different ADC's or the same ADC with different sampling rates). In this program we have already realised the following experimental structure:

- The file may contain % signs. These denote comments: to the end-of-line the text is discarded from the numerical point of view.
- There are fixed keywords which explain the preceding numerical string: device name, fs or sampling frequency, full-scale value, frequency, etc. Most of these (along with the corresponding numbers) are optional.
- The comment delimiter and the keywords are in a separate ASCII file which can optionally be changed by the user.
- Example:

```
%device name: ad547
1245543      %serial number
1e3         %fs
15          %full-scale value (V)
1.12e1      %frequency of the sine wave
12         %bit number
%Measured data points from here on
1
2
7
...
```

The third solution planned in the program is the most flexible one: user-defined input read function. The user can write a MATLAB-function which opens the file, and returns with the necessary parameters (amplitude vector, time vector and full scale value of the ADC). Using this setting it is very easy to process e. g. standard wave files on a PC.

After obtaining the whole amplitude vector, the user should have the possibility to choose from the samples. Both the time limit and the amplitude limit can be set manually. The program also allows to choose from the samples graphically, using the mouse. In addition, there are also two auto-choose

modes; “Auto-choose N periods from the begin/middle/end of the file” and “Auto-choose N samples from the begin/middle/end of the file”. Both of them facilitate automatic processing.

Before processing, it is very useful if the user can set the output file parameters. Similarly to the input, three parameters can be set: the output file path and name, the output file format and the output file content. The output path can be set by the user for every output file, and the output file names are derived from the input files names with another extension. The user may choose from three different file formats (similarly to the input file): ASCII file using % signs and comments to explain the preceding string or number, a standard MATLAB mat-file, or output generated by a user-defined function.

The four parameters of the fitted sine wave, the sampling frequency and the vector of the residuals contain all information which is needed to reproduce the result. The rest is optional: saving of most of the descriptive and computed information (including the residuals and the calculated PSDF) can be enabled or disabled by the user.

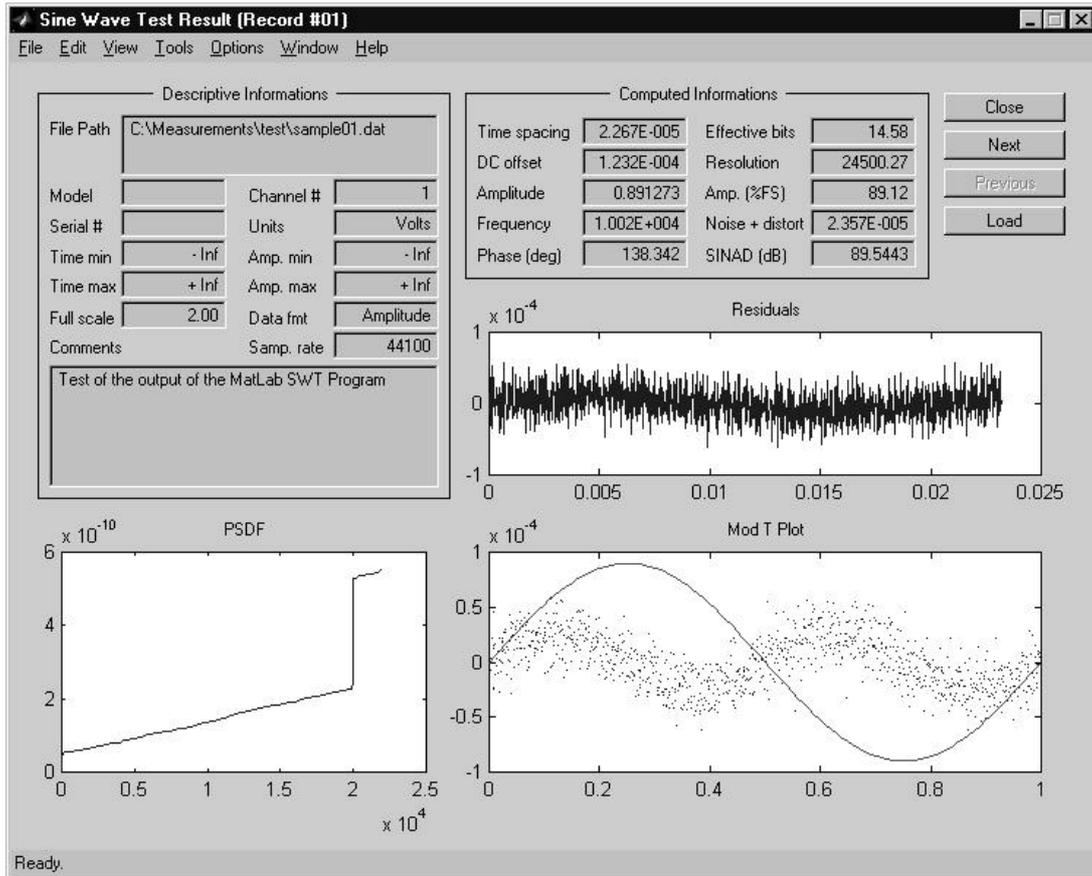


Figure 3: The output window of the MATLAB program

6.2 Computational features

After setting the whole “administrative information”, all input files are processed. The program uses the 4-parameter LS sine wave fitting using matrix operations as described in the standard and has been developed earlier [17]. For correct iteration the program uses the same initial frequency setting as the LabView one [18].

The calculation of the computed information follows the standard.

A further aim would be to cover the whole standard with just one program. It means that beyond the sine wave test a lot of other testing method should be realised. Some example:

- Measuring transfer curve and computing linearity parameters (incl. static gain and offset, integral nonlinearity, differential nonlinearity, missing codes, etc.)
- Measure and calculate step response parameters
- Measure and calculate frequency response parameters
- Allow windowed processing for incoherent sampling (as described in [4])

6.3 The output window

The main features of the graphical output are the same again as those of the LabView program. An output window of the MATLAB program can be seen in Figure 3.

One additional feature is that the blocks of the output window can be turned off, if the user would not like to see some of them. Additionally, the buttons on the upright corner help to change from one processed file to another (next, previous files).

For comparison, more than one output window can be opened, and the plots (residuals, Mod T Plot, PSDF) can be zoomed in.

7 RESULTS

Implementation aspects of two IEEE standards have been considered. The necessity of a common program for use and reference has been demonstrated. A MATLAB program, compatible to the existing LabView one, has been developed, and a suggestions for the extension have been made. The program is free, and is available through the Internet [19].

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